N-channel TrenchMOS SiliconMAX standard level FET

Rev. 01 — 16 November 2009

Product data sheet

1. Product profile

1.1 General description

SiliconMAX standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product is designed and qualified for use in computing, communications, consumer and industrial applications only.

1.2 Features and benefits

- Low conduction losses due to low on-state resistance
- Suitable for high frequency applications due to fast switching characteristics

1.3 Applications

High frequency computer motherboard DC-to-DC convertors

OR-ing applicationss

1.4 Quick reference data

Table 1.	Quick reference					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C	-	-	75	V
I _D	drain current	T_{mb} = 25 °C; V_{GS} = 10 V; see <u>Figure 1</u> and <u>3</u>	-	-	75	A
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>	-	-	230	W
Dynamic	characteristics					
Q _{GD}	gate-drain charge	V_{GS} = 10 V; I _D = 75 A; V_{DS} = 60 V; T _j = 25 °C; see <u>Figure 11</u>	-	50	-	nC
Static ch	aracteristics					
R_{DSon}	drain-source on-state resistance	V _{GS} = 10 V; I _D = 25 A; T _j = 25 °C; see <u>Figure 9</u> and <u>10</u>	-	4.3	5	mΩ



2. Pinning information

Table 2.	Pinning	information			
Pin	Symbol	Description		Simplified outline	Graphic symbol
1	G	gate			_
2	D	drain	<u>[1]</u>	mb	
3	S	source			
mb	D drain		mbb076 S		
				SOT404 (D2PAK)	

[1] It is not possible to make connection to pin 2.

3. Ordering information

Table 3.Ordering information

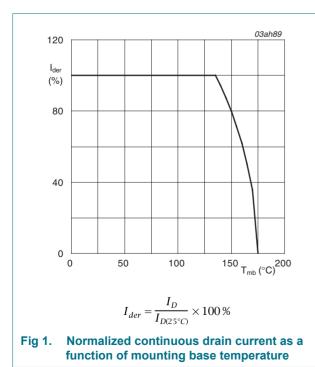
Type number	Package		
	Name	Description	Version
PSMN005-75B	D2PAK	plastic single-ended surface-mounted package (D2PAK); 3 leads (one lead cropped)	SOT404

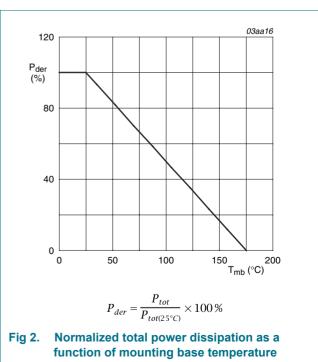
4. Limiting values

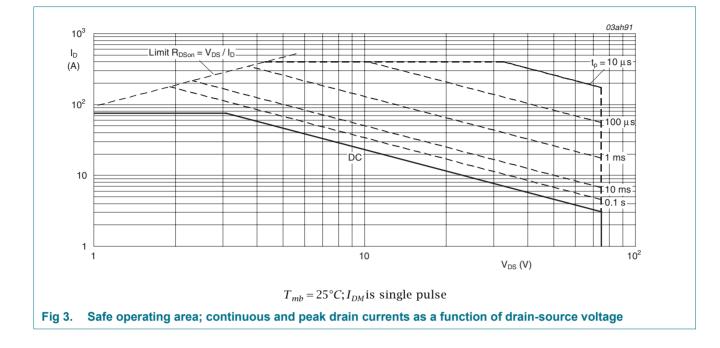
Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Мах	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C	-	75	V
V _{DGR}	drain-gate voltage	T _j ≤ 175 °C; T _j ≥ 25 °C; R _{GS} = 20 kΩ	-	75	V
V _{GS}	gate-source voltage		-20	20	V
I _D	drain current	V _{GS} = 10 V; T _{mb} = 100 °C; see <u>Figure 1</u>	-	75	А
		V_{GS} = 10 V; T_{mb} = 25 °C; see <u>Figure 1</u> and <u>3</u>	-	75	А
I _{DM}	peak drain current	$t_p \le 10 \ \mu s$; pulsed; $T_{mb} = 25 \ ^{\circ}C$; see Figure 3	-	400	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>	-	230	W
T _{stg}	storage temperature		-55	175	°C
Tj	junction temperature		-55	175	°C
V_{GSM}	peak gate-source voltage	pulsed; $t_p \leq 50~\mu s;~\delta~25~\%;~T_j \leq 150~^\circ C$	-30	30	V
Source-dr	ain diode				
I _S	source current	T _{mb} = 25 °C	-	75	А
I _{SM}	peak source current	$t_p \le 10 \ \mu s$; pulsed; $T_{mb} = 25 \ ^\circ C$	-	400	А
Avalanche	e ruggedness				
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I_D = 75 A; V_{sup} = 15 V; unclamped; t_p = 0.1 ms; R_{GS} = 50 Ω	-	500	mJ
I _{DS(AL)S}	non-repetitive drain-source avalanche current	V_{GS} = 10 V; V_{sup} = 15 V; R_{GS} = 50 Ω ; $T_{j(init)}$ = 25 °C; unclamped	-	75	A

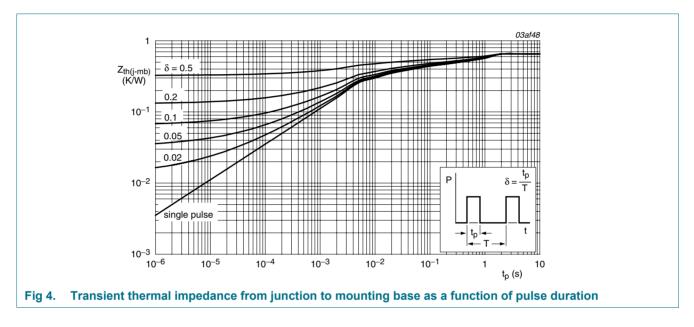






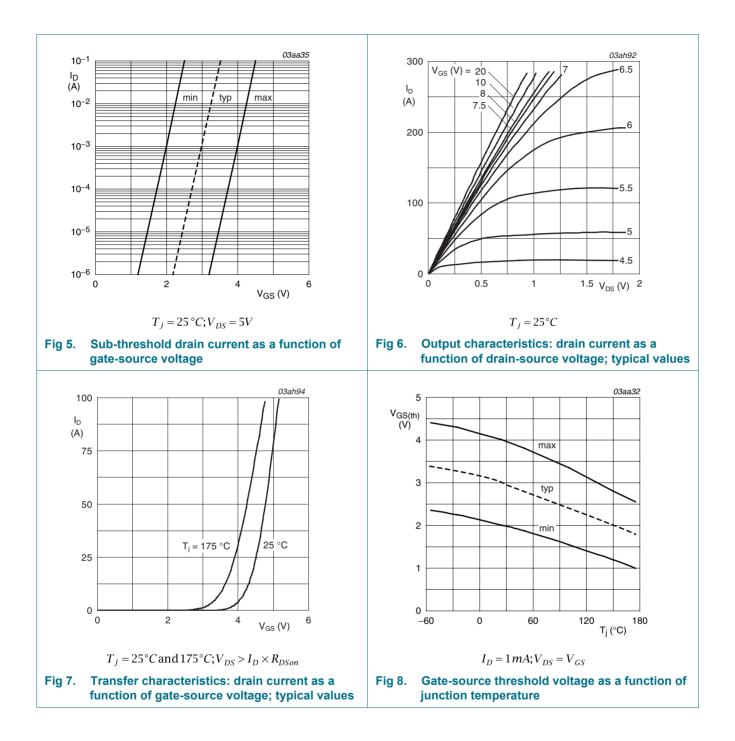
5. Thermal characteristics

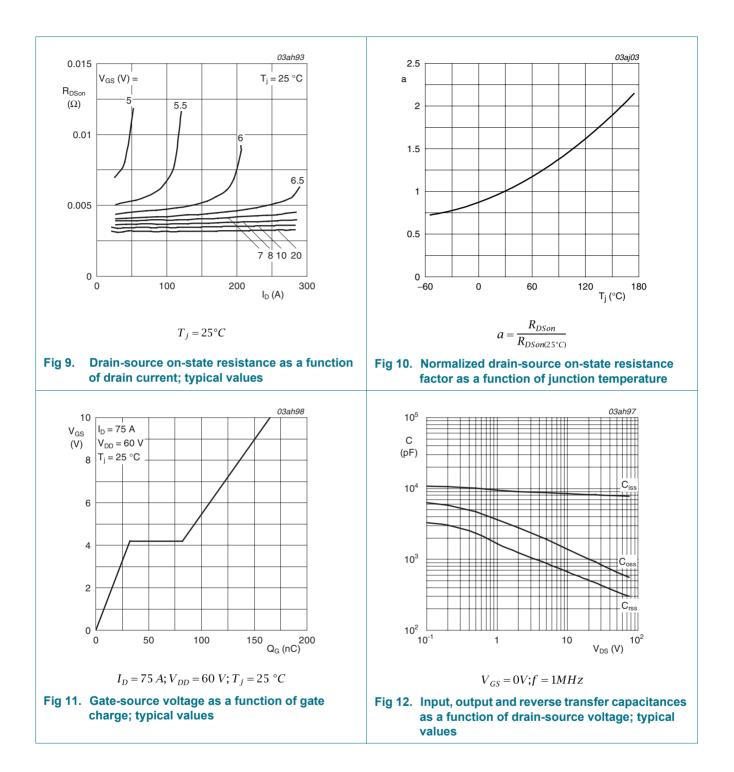
Table 5.	Thermal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base	see Figure 4	-	-	0.65	K/W
R _{th(j-a)}	thermal resistance from junction to ambient	mounted on a printed-circuit board; minimum footprint	-	50	-	K/W

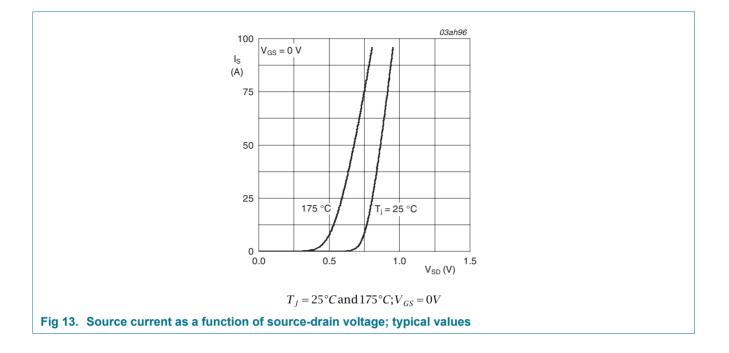


6. Characteristics

Table 6.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	aracteristics					
V _{(BR)DSS}	drain-source	I_D = 0.25 mA; V_{GS} = 0 V; T_j = -55 °C	67	-	-	V
	breakdown voltage	I_D = 0.25 mA; V_{GS} = 0 V; T_j = 25 °C	75	-	-	V
V _{GS(th)}	gate-source threshold voltage	I _D = 1 mA; V _{DS} = V _{GS} ; T _j = 175 °C; see <u>Figure 8</u>	1	-	-	V
		I _D = 1 mA; V _{DS} = V _{GS} ; T _j = 25 °C; see <u>Figure 8</u>	2	3	4	V
		I _D = 1 mA; V _{DS} = V _{GS} ; T _j = -55 °C; see <u>Figure 8</u>	-	-	4.4	V
I _{DSS}	drain leakage current	V _{DS} = 75 V; V _{GS} = 0 V; T _j = 25 °C	-	0.02	1	μA
		V _{DS} = 75 V; V _{GS} = 0 V; T _j = 175 °C	-	-	500	μA
I _{GSS}	gate leakage current	V_{GS} = 20 V; V_{DS} = 0 V; T_j = 25 °C	-	10	100	nA
		V_{GS} = -20 V; V_{DS} = 0 V; T_j = 25 °C	-	10	100	nA
R _{DSon}	drain-source on-state resistance	V _{GS} = 10 V; I _D = 25 A; T _j = 175 °C; see <u>Figure 9</u> and <u>10</u>	-	9.25	10.75	mΩ
		V _{GS} = 10 V; I _D = 25 A; T _j = 25 °C; see <u>Figure 9</u> and <u>10</u>	-	4.3	5	mΩ
Dynamic	characteristics					
Q _{G(tot)}	total gate charge	I_D = 75 A; V_{DS} = 60 V; V_{GS} = 10 V;	-	165	-	nC
Q _{GS}	gate-source charge	T _j = 25 °C; see <u>Figure 11</u>	-	32	-	nC
Q _{GD}	gate-drain charge		-	50	-	nC
C _{iss}	input capacitance	V_{DS} = 25 V; V_{GS} = 0 V; f = 1 MHz;	-	8250	-	pF
C _{oss}	output capacitance	T _j = 25 °C; see <u>Figure 12</u>	-	920	-	pF
C _{rss}	reverse transfer capacitance		-	470	-	pF
t _{d(on)}	turn-on delay time	V_{DS} = 15 V; R _L = 1.25 Ω; V _{GS} = 10 V;	-	37	-	ns
t _r	rise time	$R_{G(ext)} = 6 \Omega; T_j = 25 °C$	-	73	-	ns
t _{d(off)}	turn-off delay time		-	144	-	ns
t _f	fall time		-	74	-	ns
Source-d	rain diode					
V _{SD}	source-drain voltage	I _S = 25 A; V _{GS} = 0 V; T _j = 25 °C; see <u>Figure 13</u>	-	0.8	1.2	V







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7. Package outline

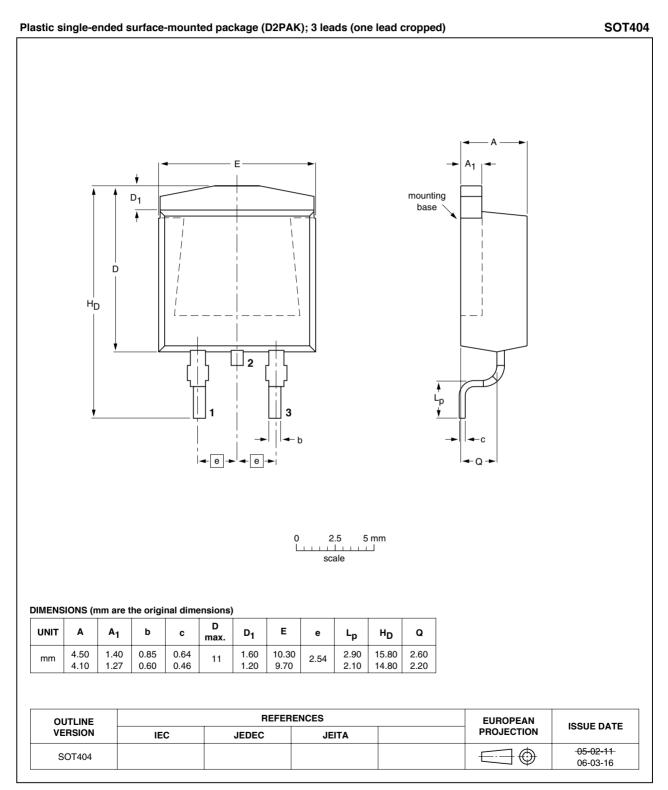


Fig 14. Package outline SOT404 (D2PAK)

8. Revision history

Table 7. Revision hi	Revision history					
Document ID	Release date	Data sheet status	Change notice	Supersedes		
PSMN005-75B_1	20091116	Product data sheet	-	-		

9. Legal information

9.1 Data sheet status

Document status [1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions"

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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